ECELCAH5VU

Ultra Low Capacitance Array for ESD Protection

The ECELCAH5VU provides a typical line to line capacitance of 0.2pF between I/O pins and low insertion loss up to 3GHz providing greater signal integrity making it ideally suited for HDMI applications, such as Digital TVs, DVD players, Computing, set-top boxes and MDDI applications in mobile computing devices.

It has been specifically designed to protect sensitive components which are connected to high-speed data and transmission lines from overvoltage caused by ESD(electrostatic discharge), CDE (Cable Discharge Events),and EFT (electrical fast transients).

Features

- Protects two or four I/O lines
- Low capacitance:0.2pf Typical between I/O channel
- Working voltages : 5V
- Low leakage current
- Response Time is < 1 ns
- Meets MSL 1 Requirements
- Solid-state silicon avalanche technology
- ROHS compliant
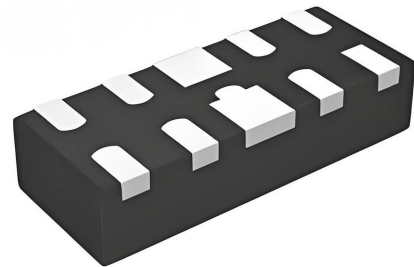
Main applications

- High Definition Multi-Media Interface (HDMI1.3/1.4/2.0)
- Digital Visual Interface (DVI)
- Display Port　Interface
- Serial ATA
- PCI Express
- USB 1.1/2.0/3.0/3.1/OTG
- IEEE 1394 Firewire Ports
- Projection TV Monitors and Flat Panel Displays
- Notebook Computers
- Set Top Box
- Projection TV

Protection solution to meet

- IEC61000-4-2 (ESD) ±15kV (air), ±8kV (contact)
- IEC61000-4-4 (EFT) 40A (5/50ns)
- IEC61000-4-5 (Lightning) 5A (8/20μs)

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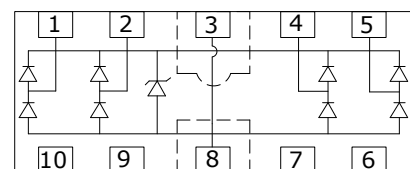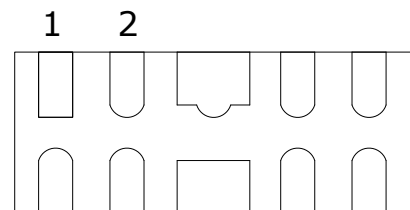
Ordering Information

Device	Qty per Reel	Reel Size
ECELCAH5VU	3000	7 Inch

Maximum ratings (Tamb=25℃ Unless Otherwise Specified)

Parameter	Symbol	Value	Unit
Peak Pulse Power (tp=8/20μs waveform)	P_{PPP}	100	Watts
Peak Pulse Current(tp=8/20μs waveform)	I_{PP}	5	A
ESD Rating per IEC61000-4-2： Contact Air		8 15	KV
Lead Soldering Temperature	T_L	260 (10 sec.)	℃
Operating Temperature Range	T_J	-55 ~ 150	℃
Storage Temperature Range	T_{STG}	-55 ~ 150	℃

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

*Other voltages may be available upon request.*

1. Non-repetitive current pulse, per Figure 1.

Electrical characteristics (Tamb=25℃ Unless Otherwise Specified)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
V_{RWM}	Reverse Working Voltage	Any I/O to Ground			5.0	V
V_{BR}	Reverse Breakdown Voltage	IT = 1mA, Any I/O to Ground	6.0			V
I_R	Reverse Leakage Current	V_{RWM} = 5V, Any I/O to Ground			1	μA
V_F	Diode Forward Voltage	IF = 15mA		0.85	1.2	V
V_C	Clamping Voltage	I_{PP} = 1A, tp =8/20μs, any I/O pin to Ground			9.8	V
		I_{PP} = 5A, tp =8/20μs, any I/O pin to Ground		13	18	V
R_{dyn}	dynamic resistance	positive transient(8/20us) negative transient(8/20us)		0.625 0.7		Ω
C_J	Junction Capacitance	V_R = 0V, f = 1MHz, between I/O pins		0.20		pF
		V_R = 0V, f = 1MHz, any I/O pin to Ground		0.5	0.65	pF

Junction capacitance is measured in VR=0V,F=1MHz

Symbol	Parameter
V_{RWM}	Working Peak Reverse Voltage
V_{BR}	Breakdown Voltage @ I_T
V_C	Clamping Voltage @ I_{PP}
I_T	Test Current
I_{RM}	Leakage current at V_{RWM}
I_{PP}	Peak pulse current
C_O	Off-state Capacitance
C_J	Junction Capacitance
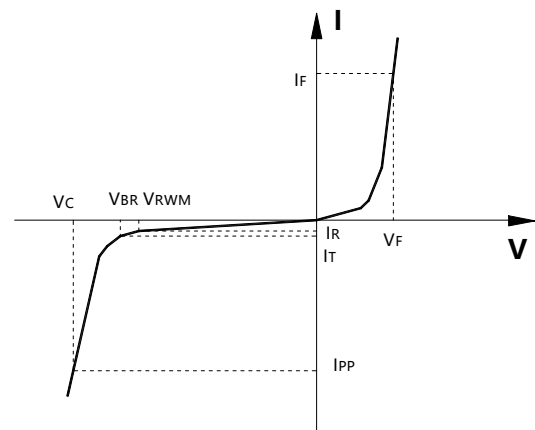
Typical electrical characterist applications

Waveform Parameters:
tr=8us
td=20us

td=IPP/2
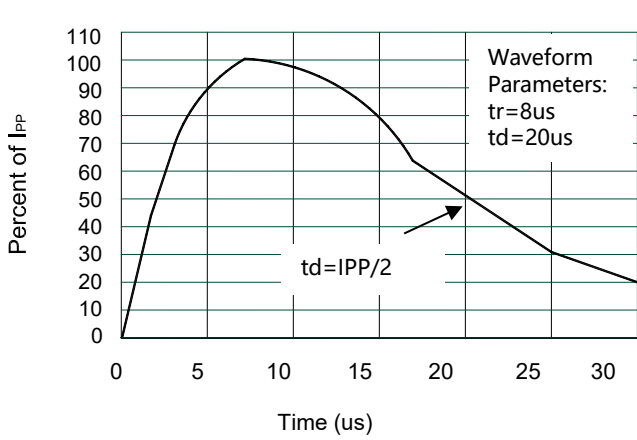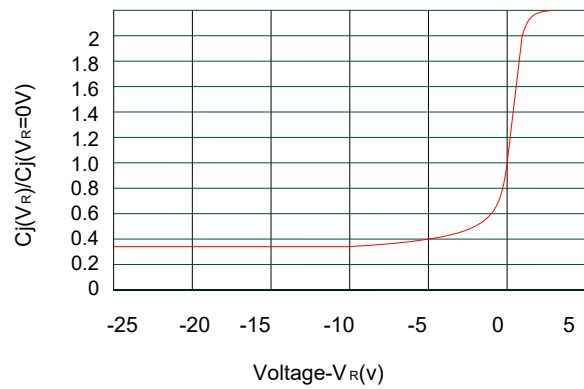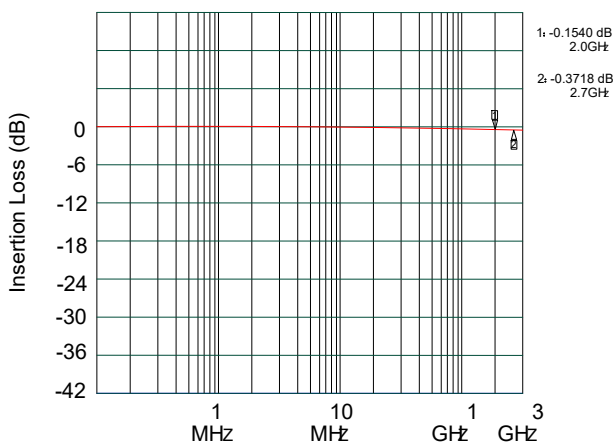
Pulse Waveform
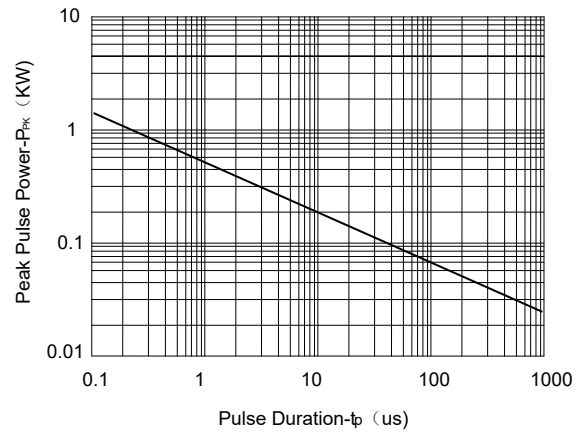
Non-Repetitive Peak Pulse Power vs. Pulse Time
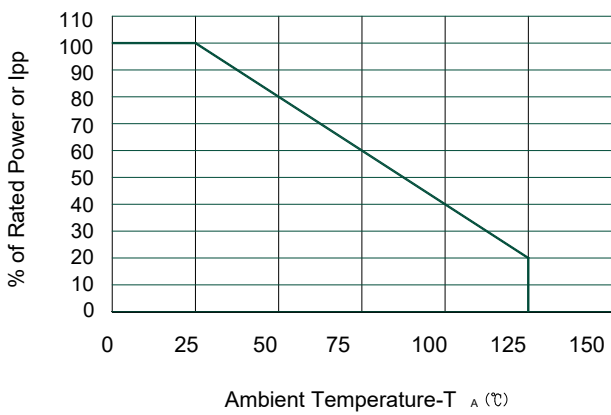
Power Derating Curve

Junction Capacitance vs. Reverse Voltage

1: -0.1540 dB
2.0GHz

2: -0.3718 dB
2.7GHz

Insertion Loss S21

Package Information

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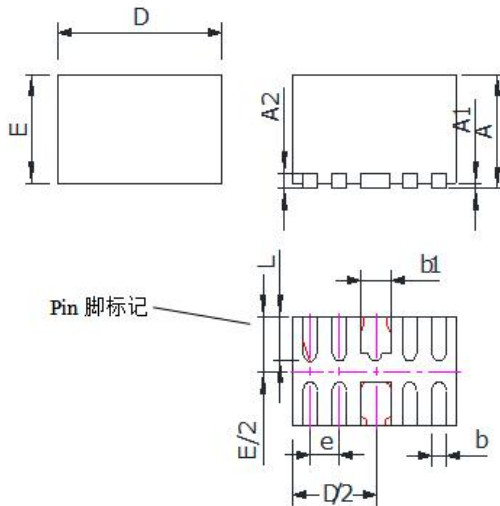
DIM	Millimeters	
	Min	Max
A	0.45	0.65
A1	0.05REF	
A2	0.15REF	
b	0.15	0.25
b1	0.30	0.50
D	2.424	2.576
E	0.924	1.076
e	0.50REF	
L	0.30	0.45

Recommended Pad outline